

<b>Notice of References Cited</b>		Application/Control No.	Applicant(s)/Patent Under Reexamination DESAI ET AL.	
		Examiner Marc S. Zimmer	Art Unit 1712	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,180,726	01-2001	Eklund et al.	525/408
	B	US-6,482,536	11-2002	Tanaka et al.	428/626
	C	US-4,883,717	11-1989	Kitamura et al.	428/458
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	JP 56047446 A	04-1981	Japan	OGAWA et al.	C08L 67/02
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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